## Ryo Kishida

## List of Publications by Year in descending order

Source: https://exaly.com/author-pdf/2817326/publications.pdf

Version: 2024-02-01

3311381 3475538 3 13 1 1 citations g-index h-index papers 3 3 3 11 docs citations times ranked citing authors all docs

#	Article	IF	CITATIONS
1	An Aging Degradation Suppression Scheme at Constant Performance by Controlling Supply Voltage and Body Bias in a 65 nm Fully-Depleted Silicon-On-Insulator Process. , 2022, , .		1
2	Bias Temperature Instability Depending on Body Bias through Buried Oxide (BOX) Layer in a 65 nm Fully-Depleted Silicon-On-Insulator Process. , 2021, , .		1
3	Extracting Voltage Dependence of BTI-induced Degradation Without Temporal Factors by Using BTI-Sensitive and BTI-Insensitive Ring Oscillators. IEEE Transactions on Semiconductor Manufacturing, 2020, 33, 174-179.	1.7	11